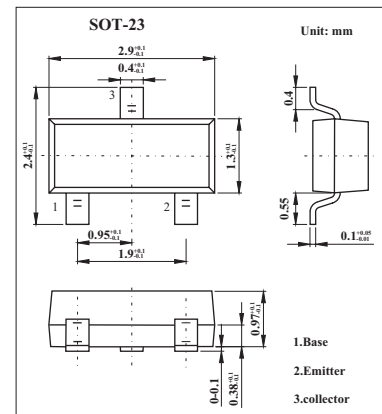


## NPN Silicon Epitaxial Transistor

## 2SC1621

## ■ Features

- High speed :  $t_{stg}=20\text{ns}$  MAX.

■ Absolute Maximum Ratings  $T_a = 25^\circ\text{C}$ 

Parameter	Symbol	Rating	Unit
Collector to base voltage	$V_{CBO}$	40	V
Collector to emitter voltage	$V_{CEO}$	20	V
Emitter to base voltage	$V_{EBO}$	5	V
Collector current (DC)	$I_C$	200	mA
Total power dissipation	$P_T$	200	mW
Junction temperature	$T_j$	150	$^\circ\text{C}$
Storage temperature range	$T_{stg}$	-55 to +150	$^\circ\text{C}$

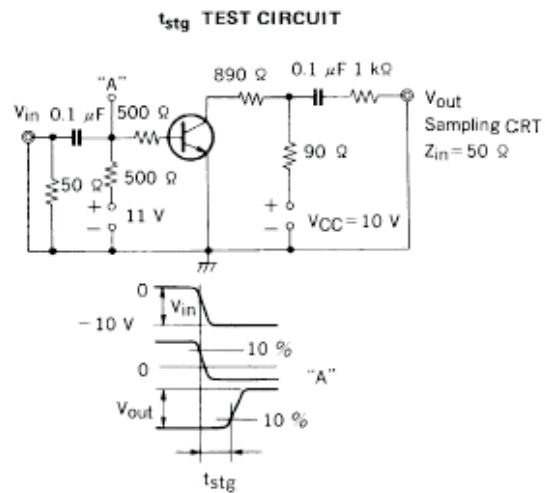
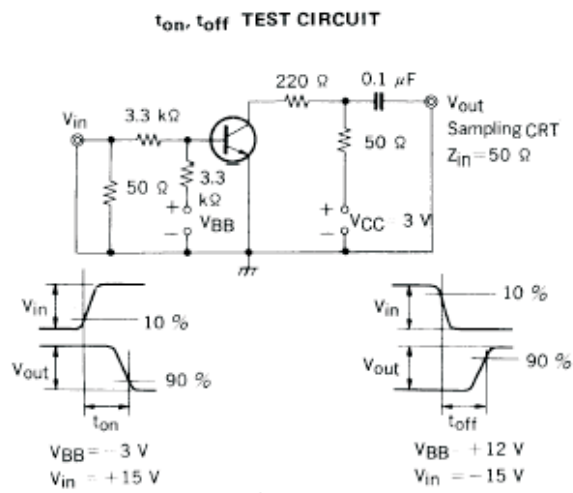
■ Electrical Characteristics  $T_a = 25^\circ\text{C}$ 

Parameter	Symbol	Testconditions	Min	Typ	Max	Unit
Collector cutoff current	$I_{CBO}$	$V_{CB} = 30\text{V}, I_E = 0$			100	nA
Emitter cutoff current	$I_{EBO}$	$V_{EB} = 4\text{V}, I_C = 0$			100	nA
DC current gain *	$h_{FE}$	$V_{CE} = 0.5\text{V}, I_C = 1\text{mA}$	40	80	180	
Collector-emitter saturation voltage *	$V_{CE(sat)}$	$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.13	0.25	V
Base-emitter saturation voltage *	$V_{BE(sat)}$	$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.74	0.85	V
Gain bandwidth product	$f_T$	$V_{CE} = 10\text{V}, I_E = -10\text{mA}$	200	500		MHz
Output capacitance	$C_{ob}$	$V_{CB} = 10\text{V}, I_E = 0, f = 1.0\text{MHz}$		3.0	6.0	pF
Turn-on time	$t_{on}$	See Test Circuit		12	20	ns
Storage time	$t_{stg}$			7	20	ns
Turn-off time	$t_{off}$			18	40	ns

\*.  $PW \leq 350\mu\text{s}$ , duty cycle  $\leq 2\%$

## 2SC1621

### SWITCHING TIME TEST CIRCUIT



#### ■ hFE Classification

Marking	B2	B3	B4
hFE	40~80	60~120	90~180